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Separable scatter model of the detector and object contributions using continuously thickness-adapted kernels in CBCT

Navnina Bhatia^{a,*}, David Tisseur^a, Solene Valton^b and Jean Michel Létang^c

Abstract. Due to the increased cone beam coverage and the introduction of flat panel detector, the size of X-ray illumination fields has grown dramatically in Cone Beam Computed Tomography (CBCT), causing an increase in scatter radiation. Existing reconstruction algorithms do not model the scatter radiation, so scatter artifacts appear in the reconstruction images. The contribution of scattering of photons inside the detector itself becomes prominent and challenging in case of X-ray source of high energy (over a few 100 keV) which is used in typical industrial Non Destructive Testing (NDT). In this paper, comprehensive evaluation of contribution of detector scatter is performed using continuously thickness-adapted kernels. A separation of scatter due to object and the detector is presented using a four-Gaussian model. The results obtained prove that the scatter correction only due to the object is not sufficient to obtain reconstruction image free from artifacts as the detector also scatters considerably. The obtained results are also validated experimentally using a collimator to remove the contribution of object scatter.

Keywords: CBCT, scatter artifact correction, CIVA, industrial NDT

1. Introduction

One of the well-recognized challenge of cone-beam computed tomography (CBCT) is the presence of scatter contamination within the projection images. Existing reconstruction algorithms do not model the scatter radiation. Therefore scatter artifact appears on the reconstruction images as shading, cupping effect, reduced contrast etc. This leads to overall inaccuracies in the reconstruction values.

Majority of the scatter correction techniques focus on scatter contribution from the object only. But recent studies [1] [2] [3] have proved that in the high energy range used in industrial Non-Destructive Testing (NDT), the contribution of detector scatter also becomes important. While evaluating the role of detector in the reconstruction artifacts, a number of scattering and blurring processes within the detector need to be taken into account.

Firstly, X-ray radiation can be Compton scattered by any part of the detector surroundings like mountings, back plate or even the detector layer itself [1]. Bub et al [1] show that this scattering

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can also lead to the edge blurring of the object in the obtained projections. The part of the detector directly exposed to full beam, produces more Compton scattering than the part of the detector under the shadow of the highly attenuating object. This is because of attenuation of the primary intensity under the object. As a result the sharpness of the edges of the object appear degraded. This can cause additional grey levels appearing in the reconstruction leading to deformations. Another important effect at high X ray energy source is the backscattering of photons from the material behind the detector [4]. If the scintillator layer is made of low absorbing material, a large part of radiation can be transmitted to the back-plate. For the energies above K edge of the back plate, there is appreciable increase in backscattering by the production of low energy fluorescence X rays. These backscattered photons may be reabsorbed at a different site than the first interaction site. As a result the overall spatial resolution of the detector decreases.

Additionally, when X-rays interact with a phosphor (by most pronounced photo-electric effect), X-ray fluorescence photons are produced which may be reabsorbed by the detector areas adjacent to the primary x-ray interaction site. This may cause a loss of spatial resolution and an increase in image noise [5] [6]. Moreover, the fluorescence optical photon may also scatter within the scintillator layer which causes blurring, also known as veiling glare [7] [8]. Its magnitude mainly depends on the thickness and material characteristics of the detection layer.

In this article, we propose to evaluate the contribution of detector scattering at NDT energy range using continuously thickness adapted Scatter Kernel Superposition (SKS) method [9]. The continuous method takes into account better sampling of the kernels with respect to the thickness of the object to get an accurate model of variability in shape and in amplitude of the scatter kernels over the whole thickness range. However, the continuous method and other classical SKS method [10] use a two-Gaussian model for the fitting of kernels. This two-Gaussian parametrization of kernels has several shortcomings. Firstly, the scatter contributions from the detector and the object are entangled, which makes the parameter fitting of the continuous model tricky. Moreover, the high frequency contribution of the detector scatter generates a strong peak in the center pixel of the detector where the pencil beam is impinged. This shape calls for the necessity to explore an increase in order of the Gaussian model. Therefore, we propose in this paper, by means of both experiments and simulations, to identify the respective scatter contributions of the object and detector using a four-Gaussian model to have a more stable modeling.

We begin by outlining the four-Gaussian analytic description of the kernels. Subsequently, the CBCT acquisition set up is described in detail. An in-depth analysis of the four-Gaussian contributions is carried out in Section 3. Experimental validation is finally performed with both fan beam and cone beam geometries.

2. Method and materials

2.1. Four-Gaussian model

In the SKS scatter correction approach with continuously thickness-adapted kernels [9], the scatter signal can be modeled as the sum of the scatter contributions from a group of pencil beams passing through the object and the detector. For each pencil beam input, a resulting kernel which has the weight of the scatter to primary ratio is determined. The total scatter signal S(m, n) with m and n as the pixel position on the detector, can then be modeled as:

$$S(m,n) = \sum_{k} \sum_{l} P(k,l) h_{T(k,l)}(m-k,n-l)$$
 (1)

where, h_T is the thickness (T) dependent kernel, with amplitude equal to the ratio of the scattered signal at the current pixel to the primary signal, at the pencil beam centered pixel. The sum in the convolution process runs over all pixels (k, l) of the detector. P is the primary signal contributed by the photons passing directly without any attenuation. Instead of using Beer-Lambert law based on an effective linear attenuation coefficient [10], the thickness T(k, l) in Equation 2 is directly computed from a look-up table f_{BH} – computed during the calibration stage of the kernels – that relates the true slab thickness with respect to the transmittance

$$T(k,l) = f_{BH} \left(\frac{P(k,l)}{O(k,l)} \right) \tag{2}$$

where O is the unattenuated image. It is worthy to note that the beam-hardening is taken care of with this procedure. The acquisition parameters and the material of the calibration slabs must be the same as the object under study. Value of directly transmitted primary fluency P were calculated for each thickness of the simulated slab. The thickness in terms of the transmittance P(k, l)/O(k, l) is calculated as described in Section 3.1.

The pencil beam kernel h_T can be fitted into the equation formed by four circularly symmetric Gaussian functions describing the shape of the kernel:

$$h_T(m-k, n-l) = A \exp\left(-\frac{(m-k)^2 + (n-l)^2}{2\sigma_1^2}\right) + B \exp\left(-\frac{(m-k)^2 + (n-l)^2}{2\sigma_2^2}\right) + C \exp\left(-\frac{(m-k)^2 + (n-l)^2}{2\sigma_3^2}\right) + D \exp\left(-\frac{(m-k)^2 + (n-l)^2}{2\sigma_4^2}\right)$$
(3)

The four-Gaussian model is necessary in order to clearly separate the contributions of the object and of the detector.

2.2. Kernel generation and fitting

Monte Carlo (MC) simulations were performed in the CT module of CIVA software [11] for the generation of kernels. Pencil beam source was impinged on slabs of same material as the object under study and discrete set of point spread 2D kernels were obtained on the flat panel detector.

The flat panel was modeled in a standard multi-layer representation consisting of 0.1 mm aluminium front layer followed by air-gap of 0.8 mm, a 0.06 mm CsI layer, 1 mm silicon substrate and finally a 1 mm lead back plate.

The eight parameters of Equation 3, A, B, C, D, σ_1 , σ_2 , σ_3 , σ_4 are also interpolated in terms of thickness to obtain a continuous kernel map with respect to thickness [9]. We have used a four-Gaussian model in order to separate the contribution of object and detector. To get realistic kernels and in particular to take into account optical processes in the detector, real acquisitions on slabs of various thickness could also be advantageously used in practice with an X-ray pencil beam geometry.

2.3. Acquisition set up with aluminum turbo

For the acquisition set up, the source to detector distance was 845 cm and the distance between source and axis of rotation was at 424 cm. The set up mainly consisted of a X-ray source, an object rotational table and a flat panel detector. The X-ray source unit of maximum 230 kV was used. A



Fig. 1. Picture of sample of the aluminum turbo.

copper filter of 0.35 mm was used in the spectrum. Flat panel detector used had a size 1840×1456 with 2×2 binning size and 0.254 mm pixel size.

Acquisitions were performed on an aluminum turbo as given in Fig. 1 which had a maximum dimension of around 300 mm.

2.4. Acquisition set-up with collimator slit

In order to validate our results with experimental results, acquisitions were performed with a collimator slit inserted in between the object and the detector. The set up is described in Fig. 2. The collimator slit was made of steel with a thickness of 30 mm and width 15 mm. The introduction of the collimator removed approximately all the contribution of the object scatter.

3. Results

3.1. Analytical fitting of calculation of thickness

As discussed in Section 2.1, in order to calculate the thickness at each pixel, simulation were performed with slabs of different thickness. The acquisition parameters and the material of the slabs was kept the same as the object under study. Value of directly transmitted primary fluency P were calculated for each thickness of the simulated slab.

The thickness vs transmittance LUT f_{BH} given in Equation 3 has been analytically calculated using least square fitting as shown in Fig. 4 to determine the coefficients a_1 , b_1 , a_2 , b_2 in Equation 4. The classical thickness determination based on the effective linear attenuation coefficient is also shown by the red curve in Fig. 4. The beam-hardening, although not really strong, is clearly visible. Equation 4 gives the relationship of thickness T value in terms of transmittance P(k, l)/O(k, l).

$$T(k,l) = f_{BH} \left(\frac{P(k,l)}{O(k,l)} \right)$$

$$= -a_1 \ln \left(\frac{P(k,l)}{O(k,l)} \right)^{b_1} - a_2 \ln \left(\frac{P(k,l)}{O(k,l)} \right)^{b_2}$$
(4)

using $a_1 = 20.8$, $b_1 = 0.83$, $a_2 = 0.000572$, $b_2 = 1$

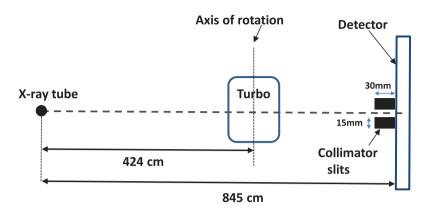


Fig. 2. Schematic of the acquisition set up with the collimator slit.

3.2. Analytical fitting of kernels for continuous kernel map

The fitting of parameters A, B, C, D, σ_1 , σ_2 , σ_3 , σ_4 of the four-Gaussian model with respect to thickness using least square fitting is shown in Fig. 3. From the fitting of the parameters, we observe that the standard deviation σ_1 and σ_2 vary over the thickness of the object whereas σ_3 and σ_4 remain constant. We can draw inference that σ_1 and σ_2 give the the scattering contribution of the object which increases over the thickness of the object. Moreover, we notice that σ_1 is very far from σ_2 . Henceforth, we analyze that σ_1 displays the low frequency contribution of multiple scattering inside the object, whereas σ_2 gives comparatively low order scattering contribution. We also mark not much difference in the parameters A & B which weight the amplitude of the shape of the Gaussians. This variation of parameters A, B, σ_1 , σ_2 , demonstrate that a two-Gaussian model for the object is necessary.

Similarly, observing σ_3 and σ_4 remain constant over the thickness of the object, we infer that σ_3 and σ_4 define the high frequency contribution from the detector. Following the same line of reasoning, σ_3 and σ_4 are different from each other whereas and parameters C, D are not outlying each other. Therefore, a two-Gaussian model for the detector is also crucial.

3.3. Scatter correction on aluminium turbo

Figure 5 a) displays the reconstruction slice obtained with uncorrected projections using FDK algorithm. We first evaluated the scatter contribution of the object alone and we corrected the projections with only scatter kernels of the object. The result obtained is shown in Fig. 5 b). It clearly shows that the scatter correction due to only object is not sufficient as scatter artifacts are still visible in the reconstruction image. This is also demonstrated in Fig. 6 which displays the plot profile of the corrected and uncorrected reconstruction slices. The scatter kernels of detector and object were then used to perform the corrections of the projections. The reconstruction obtained with this correction is shown in Fig. 5 c). The obtained result with the scatter correction of object and detector is in agreement with the expected value of effective linear attenuation coefficient at mean energy 98 keV (0.48 per cm).

Table 1 displays the mean and standard deviation of the reconstructed values for corrected and uncorrected data in air and aluminum region calculated using binary masks. Uncorrected value of 0.258 cm⁻¹ for the linear attenuation coefficient of aluminum is estimated. By using only object scatter kernels we obtain a value of 0.324 cm⁻¹ for the linear attenuation coefficient of aluminum. In the considered energy range, the value of linear attenuation constant per cm for mean energy 100 keV is 0.48 cm⁻¹. The relative absolute error in percentage is 32.5% for the scatter correction with object kernels. Whereas, for detector and object kernels both we obtain a value of 0.510 cm⁻¹ for the

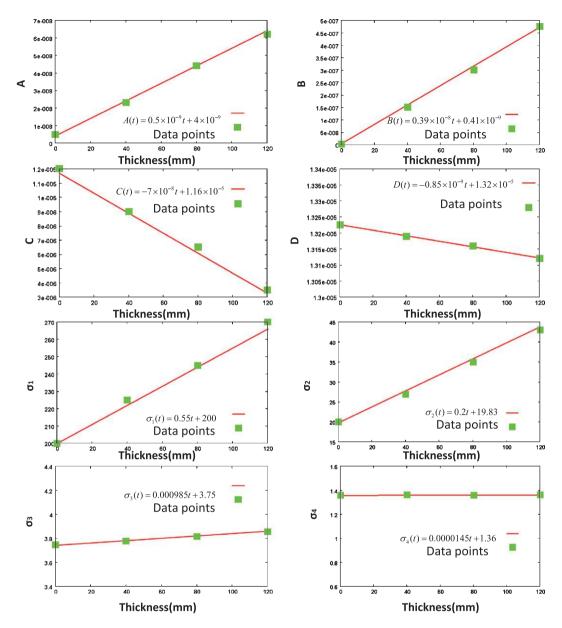


Fig. 3. Fitting of parameters A, B, C, D, σ_1 , σ_2 , σ_3 , σ_4 with thickness.

aluminum. The relative absolute error is reduced to 6.25%. The remaining artifact that we see in the scatter corrected reconstruction arise from the very high attenuation along the largest dimension of the object. The dynamic range of the detector was not high enough to take into account the attenuation along the highest dimension.

3.4. Validation by experimental result using a collimator

In order to validate the results obtained with the continuously thickness adapted SKS scatter correction algorithm, we performed acquisitions using a collimator made of steel with 30 mm thickness.

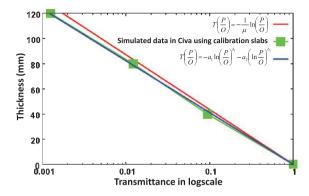


Fig. 4. Fitting of thickness Vs transmittance curve to obtain correct value of thickness in terms of transmittance.

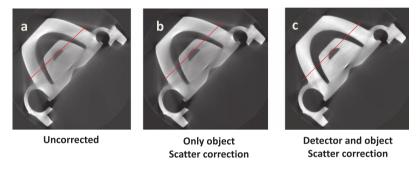


Fig. 5. Reconstruction slice with a) uncorrected projections b) corrected projections by only scatter kernels c) corrected projections by scatter and detector kernels.

The set up is described in the Section 2.4. Fan beam was produced and the contribution of the scatter from the object was eliminated by introducing a collimator slit between the object and the detector. All the other acquisition parameters were kept same as the previous set up without the collimator slit. The reconstruction was performed on the projections obtained with this set up and the result is shown in Fig. 7 a). It clearly shows the presence of scatter artifacts due to detector. We compare this experimental result with the result obtained by scatter correction performed by the algorithm using only object scatter kernels shown in Fig. 7 b). Figure 8 compares the plot profile of the experimental result with the collimator and scatter correction by the algorithm using object scatter kernels. The plot profiles demonstrate identical results validating the results obtained by the algorithm and proving considerable contribution of detector scatter.

Table 2 displays the mean and standard deviation of the reconstructed values for air & aluminum region for experimental result and correction with object scatter kernels. The linear attenuation coefficient obtained for aluminum and air is $0.312~\rm cm^{-1}$ and $0.096~\rm cm^{-1}$ respectively for the experimental result. This is in agreement with the scatter correction with object kernels result which is $0.324~\rm cm^{-1}$ for aluminum and $0.106~\rm cm^{-1}$ for air. In the considered energy range, the value of linear attenuation coefficient for mean value of spectrum ($100~\rm keV$) is $0.48~\rm cm^{-1}$ and $0.0001~\rm cm^{-1}$ for aluminum and air respectively. This result demonstrates that in the considered energy range, object scatter correction is not sufficient and the detector scatter contribution also needs to be taken into account to obtain correct reconstruction values.

Table 1

Mean and standard deviation values for aluminum and air region for uncorrected and corrected reconstruction slices

		mean (cm ⁻¹)	std. dev.
Uncorrected	aluminium	0.258	± 0.0079
	air	0.098	± 0.0054
Object scatter correction	aluminium	0.324	± 0.0061
	air	0.106	± 0.0056
Object and detector scatter correction	aluminium	0.510	± 0.0078
	air	0.0008	± 0.0036
Mean spectrum value	aluminium	0.48	
	air	0.0001	

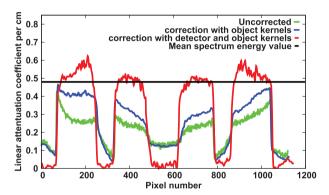


Fig. 6. Plot profile of uncorrected and corrected reconstruction slice by only scatter kernels and scatter and detector kernels.

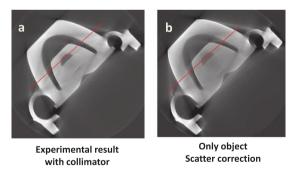


Fig. 7. Reconstruction slice by a) experimental results with collimator b) corrected projections by only object scatter kernels.

4. Discussion and conclusion

The analytical description of the scatter kernels using four-Gaussian model separates the low frequency contribution of scatter due to object and the high frequency contribution of the detector. This separation of the contributions is necessary to clearly follow the effect of detector scatter on the reconstruction in CBCT by developing a separate model for the detector.

The object scatter itself requires a two-Gaussian model to take into account higher order and lower order scattering from the object. The amplitude parameters of scatter kernels A&B increase with

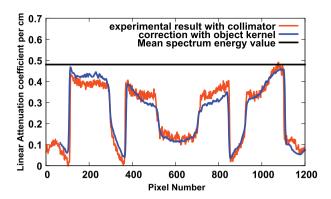


Fig. 8. Plot profile of experimental result with collimator and scatter correction with object scatter kernels.

Table 2

Mean and standard deviation values for aluminium and air region for experimental result with collimator and correction with object scatter kernels

		mean(cm ⁻¹)	std.dev
Experimental result with collimator	aluminium	0.312	± 0.0056
	air	0.096	± 0.0023
Correction with object scatter kernels	aluminium	0.324	± 0.0090
	air	0.106	± 0.0067
Theoretical values	aluminium	0.48	
	air	0.0001	

increase in thickness of the object because of the increase in SPR. σ_1 representing the very low frequency contributions from the object after multiple scattering of photons and σ_2 representing comparatively high frequency contribution from the object after fewer scattering of the photons, both increase with the thickness of the object. Similarly, the high frequency contribution of the detector model also requires a two-Gaussian model. The amplitude parameters for the detector Gaussian, C&D, decrease with thickness. Due to higher attenuation, lesser primary intensity reaches the detector leading to fewer Compton scattering events in the detector and its surrounding. Also, D, which weights the high frequency detector contribution, remains constant while C, which weights comparatively lower frequency detector contribution, decreases with respect to thickness. One explanation to this behavior could be that C is related to the back scattering from the back plate and since effective energy increases with respect to thickness, the scattering from the back plate becomes less and less back scattered. Whereas, D could be related to florescence in the scintillator, which remains constant over the thickness. The high frequency contribution of the detector given by σ_3 , σ_4 remain constant over the thickness of the object.

Using this analytical description of the scatter kernels, the projections were corrected to perform a comprehensive study of the contributions of object and detector scattering. The correction of projections using only object scatter kernels produced reconstruction image with scatter artifact. The relative absolute error with respect to the expected value is 32.5% for the scatter correction with object kernels. The correction of projections using object and detector scatter kernels reduced the relative error to 6.25%. The results obtained were validated with experimental results using a collimator. The relative absolute error between the experimental result using collimator and the scatter correction using object kernel was 3.7%.

The obtained result proves in this particular case study that the correction of the scatter due to the object only is not sufficient to completely remove scatter artifact in the reconstruction. The contribution of the detector scattering is very significant at the energy range used. We remark that the detector scatter depends on several parameters including the spectrum used and components (front filter, back plate etc.) configuration of the detector. The importance of the contribution of the detector scatter over the object scatter will therefore depend on each case study. Although the information about the component structure of the detector was only approximate in the simulation model of this study as it is generally kept anonymous by the manufacturer - the improvement in the scatter reduction using both object and detector scatter kernels is noteworthy. To further improve the realism of the detector kernels, either a more accurate 3D description of the detector could be used in the Monte Carlo simulation instead of a simple multi-layer model or direct measurements of the detector kernel could be carried out. Moreover, it could be additionally possible to implement a detector-specific tuning of the apodization function of the FDK reconstruction, for example, by measuring the noise power spectrum of the detector to take into account the detector variability of noise levels.

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